

Search Notes

Application/Control No.

10/757,274

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	238, 241- 244, 256- 258	10/5/2006	HP
372	50.124	10/5/2006	HP
362	285	10/5/2006	HP
359	248	10/5/2006	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	10/4/2006	HP
EAST Text Search	10/5/2006	HP